

| CUSTOMER: | DATE: |
|-----------|--------------|
|-----------|--------------|

APPROVAL SPECIFICATION

ROHS+HS
COMPLIANT
AEC-Q200

| PRODUCT NAME: SMD power inductor | 1 |
|------------------------------------|------|
| YOUR PART NO.: | |
| OUR PART NO.: AMPSM201208BE-21 ser | ries |
| VERSION: V1.0 | .00 |

| RECEPTION | RECEPTION | | | | | |
|----------------|---------------------|------|--|--|--|--|
| THE SPECIFICAT | TION HAS BEEN ACCEP | TED. | | | | |
| COMPANY: | COMPANY: DATE: | | | | | |
| CFMD | CHKD | RCVD | | | | |
| | | | | | | |

MANUFACTURING NAME

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| CFMD. | CHKD. | DSGD. |
|---------|-----------------|---------|
| Charles | Wang Yusheng | Liu Wei |



CATALOG

| | Component SPEC Version Record | 3 |
|---|---------------------------------|-----|
| 1 | Scope | 4 |
| 2 | Product Identification | 4 |
| 3 | Appearance and Dimensions | 4 |
| 4 | Testing Conditions | |
| 5 | Electrical Characteristics | 5 |
| 6 | Reliability | 6-8 |
| 7 | Recommended Soldering Condition | 9 |
| 8 | Packaging. | |
| 9 | Products Storage. | 11 |



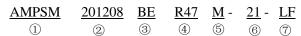
Component SPEC Version Record

| Rev. | Effective Date | Changed Contents | Change Reasons | Approved By |
|------|----------------|------------------|----------------|-------------|
| V1.0 | 2019.12.25 | New released | / | Charles |
| | | | | |

1. Scope

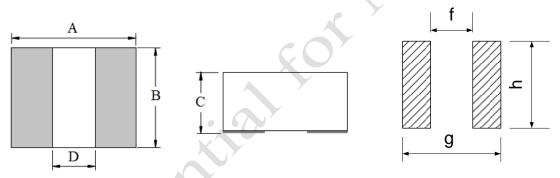
This specification applies to the AMPSM201208BE series of SMD power inductor. AEC-Q200 qualified.

2. Product Identification



- ① Product Symbol. (Automotive electronics products)
- 2 Product dimensions.
- ③ Special process code.
- 4 Inductance Value: (R47: 0.47uH 1R0: 1.0uH 100:10uH)
- 5 Inductance Tolerance: (M: ±20%; N: ±30%)
- 6 Process code
- 7 Lead free product.

3. Appearance and Dimensions



Note: Gray area is electrode

Recommended Land Pattern

| Dimensions in mm | | | | | | |
|------------------|-----------|-----------|-----------|-----------|-----------|-----------|
| A B C D f g h | | | | | h | |
| 2.00±0.20 | 1.20±0.20 | 0.80 max. | 0.60±0.20 | 0.50 Typ. | 2.10 Typ. | 1.30 Typ. |



4. Testing Conditions

Unless otherwise specified, the standard conditions for measurement/test as:

Ambient Temperature : 5 to 35 °C Relative Humidity: 25 to 85% RH Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits:

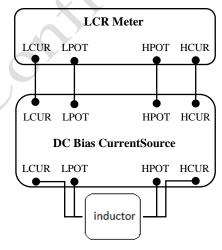
Ambient Temperature : 25±1°C Relative Humidity: 60 to 70% RH Atmospheric Pressure: 86 to 106 kPa

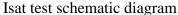
5. Electrical Characteristics And Test Instruments

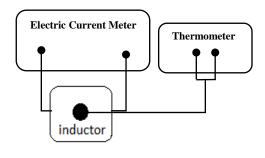
| Microgate Part No. | Inductance L0 (uH) | DCR (mΩ) | | Isat (A) | Isat | Irms (A) | Irms |
|------------------------|-----------------------|----------|------|-------------|-------------|-------------|-------------|
| wherogate I art no. | 1.0MHz/1V | Max | Тур. | Max. | (A) Typ. | Max. | (A) Typ. |
| AMPSM201208BER47M21-LF | 0.47±20% | 33 | 26 | 4.3 | 4.8 | 3.7 | 3.9 |
| AMPSM201208BE1R0M21-LF | 1.0±20% | 72 | 60 | 3.3 | 3.8 | 3.2 | 3.5 |
| AMPSM201208BE2R2M21-LF | 2.2±20% | 158 | 140 | 1.9 | 2.1 | 1.6 | 1.8 |

Test instruments and remarks

- * All test data is referenced to 25°C ambient.
- * L test by CHROMA 3302 meter or equivalent
- * DCR test by Tonghui TH2516B meter or equivalent
- * CHROMA 3302 and 1320 meter for IDC;
- * Isat: DC current (A) that will cause L0 to drop approximately 30%.
- * Irms: DC current (A) that will cause an approximate ΔT of 40°C.
- * Operating temperature: -55° C to $+155^{\circ}$ C (Including self temperature rise).
- * The part temperature (ambient + temp rise) should not exceed 155 °C under worse case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provision all affect the part temperature. Part temperature should be verified in the end application.







Irms test schematic diagram

5/11

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6. Reliability

| No. | Item | Requirements | Test Methods and Remarks | Reference | Sample Size |
|-----|------------------------------------|---|---|--|----------------|
| 1 | Solderability | (1) No physical damage.(2) Terminal area must have 95% min. solder coverage. | ①Temperature:245±5°C, flux 5-10 s. ②Sample immersion tin furnace 5 ±0.5s. ③Immersed and in and out of speed: 25 ±6mm/s. | AEC-Q200 (J-STD-002) | 15 |
| 2 | Resistance to Soldering Heat | (1) No physical damage. (2) ΔL0/L0 ≤10% | 1) The peak temperature: 260+5/-0°C. 2) Reflow:3times. 3) Temperature curve is as below: Peak 265°C Max. Ramp Up Rate=3°C/s Max. Ramp Down Rate=-6°C/s 40-180 Fine 25°C to Peak =8 min Time | AEC-Q200 (MIL-STD-202 Method 210) | 30 |
| 3 | High Temperature Storage | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①Temperature: 155±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion. Temperature 155°C Room Temp. 0 1000H Time | AEC-Q200 (MIL-STD -202 Method 108) | 77 |
| 4 | Temperature Cycling | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①1000 cycles (-40°C to +155°C). ②30min maximum dwell time at each temperature extreme. 1 min. maximum transition time. ③Measurement at 24±4 hours after test conclusion. | AEC-Q200 (JESD22-A104) | 77 |
| 5 | Resistance to Solvents | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①Prepare solvent (isopropyl alcohol: kerosene: ethylbenzene =4:9:3 volume) ②Specimen be completely immersed in solvent for 3+0.5/-0min ③Brush dipped in solution until wetted and brush part 10 strokes. ④Repeat 2 more times, Air blow dry. ⑤Inspect at 3x magnifier for marking and 10x for part damage. Note: Add Aqueous wash chemical. OKEM Clean or equivalent. Do not use banned solvents. | AEC-Q200 (MIL-STD-202 Method 215) | 5 |



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|-----|----------------------|--|--|--|----------------|
| No. | Item | Requirements | Test Methods and Remarks | Reference | Sample Size |
| 6 | ESD | (1) No physical damage. (2) ΔL0/L0 ≤10% | ①3 times in each of terminals and top side of component. ②Direct contact discharge: 1C(1000V(DC) to <2000V(DC)) | AEC-Q200 (AEC-Q200- 002) | 15 |
| 7 | Biased Humidity | (1) No physical damage. (2) ΔL0/L0 ≤10% | ①1000 hours, 85 °C/85%RH. ②Unpowered. ③Measurement at 24±4 hours after test conclusion. | AEC-Q200 (MIL-STD -202 Method 103) | 77 |
| 8 | Terminal Strength | (1) No physical damage. (2) ΔL0/L0 ≤10% | ①The test samples shall be soldered to the board. ②17.64N, 60s Radius 0.5mm PUT Press tools Shear force | AEC-Q200 (AEC-Q200-006) | 30 |
| 9 | Board Flex | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①Part mounted on a 100mm*40mm FR4 PCB board, which is 1.6±0.2 mm thick and as a Layer-thickness 35 µm ± 10 µm. ②Bending speed is 1 mm/s. ③Keeping the P.C Board 2 mm minimum for 60 seconds. Support Solder Chip Printed circuit board before testing Printed circuit board before testing Printed circuit board under test Unit: mm | AEC-Q200 (AEC-Q200-005) | 30 |
| 10 | Vibration | (1) No physical damage. (2) ΔL0/L0 ≤10% | ①Frequency range: 10~2000Hz. ②Amplitude: 1.5mm, 5g. ③Sweep time and duration: 10~2000~10Hz for 20 minutes. ④Each four hours in X,Y,Z direction, 12 hours in total. | AEC-Q200 (MIL-STD-202 Method 204) | 30 |
| 11 | Mechanical Shock | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①Peak acceleration:100G/S ②Duration of pulse:6ms ③3times in each of 6(±X, ±Y, ±Z) axes. | AEC-Q200 (MIL-STD-202 Method 213) | 30 |



| No. | Item | Requirements | Test Methods and Remarks | Reference | Sample Size |
|-----|-----------------------------------|---|--|---------------------------|----------------|
| 12 | Loading at High Temperature | (1) No physical damage.(2) ΔL0/L0 ≤10% | ①Temperature: 105 ±2 °C. ②Time: 1000 hours. ③Applied Current: Rated current. ④Measurement at 24 ±4 hours after test conclusion. | AEC-Q200 (MIL-PRF-27) | 77 |
| 13 | Physical Dimension | According to specification | Verify physical dimensions to the applicable device detail specification. | AEC-Q200 (JESD22-B100) | 30 |
| 14 | Electrical Characterization | According to specification | Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures. | AEC-Q200 (User Spec.) | 77 |

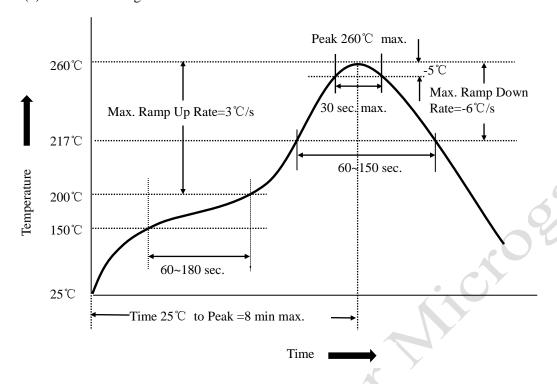
^{*}All above experiments items need 3 Lot., sample size is as specified in the table above.

^{*}Sample size standard is from AEC-Q200: qualification sample size requirements.



7. Recommended Soldering Conditions

(1) Reflow soldering conditions



^{*}Above reflow soldering curve is from J-STD-020D.

(2) Iron soldering

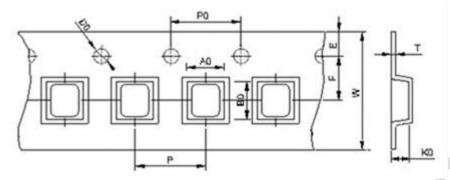
The following conditions must be strictly followed when using a soldering iron.

| | • |
|-----------------------|----------------|
| Pre-heating | 150°C 1 minute |
| Tip temperature | 350°C max |
| Soldering iron output | 30w max |
| End of soldering iron | Ф1mm max |
| Soldering time | 3 seconds max |



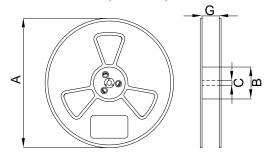
8. Packaging

(1) Dimension of tape (Unit: mm)



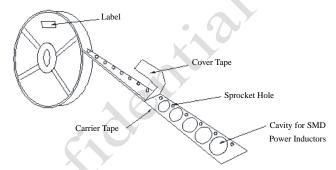
| W | A0 | В0 | K0 | E | F | P | P0 | D0 | T |
|-------------|-----------|-----------|----------|--------------|---------|---------|---------|--------------|---------------|
| 8.0 ± 0.1 | 1.60±0.10 | 2.35±0.10 | 1.00±0.1 | 1.75 ± 0.1 | 3.5±0.1 | 4.0±0.1 | 4.0±0.1 | 1.5+0.1/-0.0 | 0.18 ± 0.02 |

(2) Dimension of reel (Unit: mm)



| Symbol | Dimension |
|--------|-----------|
| A | 178±2 |
| В | 58±2 |
| С | 13.5±0.2 |
| G | 9.0±0.5 |

(3) Taping figure and drawing direction

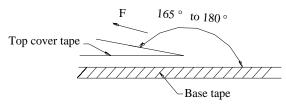


(4) Packaging quantities: 2000PCS/Reel.

(5) Peeling strength of cover tape:

The peel force of top cover tape shall be between 0.1N to 1.3N.

*the peel force standard is from EIA-481-D



| Room Temp. (°C) | Room Humidity (%) | Room aim (hpa) | Peel Speed mm/min |
|-----------------|-------------------|----------------|-------------------|
| 5-35 | 45-85 | 860-1060 | 300 |

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9. Products Storage

(1) Storage period

Products which inspected in MICROGATE over 12 months ago should be examined and used, which can be confirmed with inspection No. marked on the container. Solderability should be checked if this period is exceeded.

(2) Storage conditions

Products should be storage in the warehouse on the following conditions:

Temperature: -10 ~+ 35 °C

Humidity: Less than 70% relative and humidity. No rapid change on temperature and humidity.

- (3) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- (4) Products should be storage on the palette for the prevention of the influence from humidity, dust and so on
- (5) Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- (6) Products should be storage under the airtight packaged condition.

11/11